# AN APPLICATION OF STOCHASTIC INTEGRAL EQUATIONS TO ELECTRICAL NETWORKS

Edita KOLÁŘOVÁ

Department of Mathematics, Faculty of Electrical Engineering and Communication, Brno University of Technology, Technická 8, 616 00 Brno, Czech Republic, E-mail: kolara@feec.vutbr.cz

#### ABSTRACT

In this paper we present an application of the Itô stochastic calculus to the problem of modelling inductor-resistor electrical circuits. The deterministic model of the circuit is replaced by a stochastic model by adding a noise term in the source. We also consider the case when both the source and the resistance are random. The analytic solutions of the resulting stochastic integral equations are found using the multidimensional Itô formula. We also examined statistical estimates of the stochastic solutions. The programming language C#, a part of the new MS .NET platform, is used for numerical simulations.

Keywords: stochastic differential equations, Itô formula, RL electrical circuit, C#

#### 1. INTRODUCTION

Modelling of physical systems by ordinary differential equations ignores stochastic effects. By incorporating random elements into the differential equations, a system of stochastic differential equations (SDEs) arises.

A general *N*-dimensional SDE can be written in vector form as

$$d\mathbf{X}(t) = \mathbf{A}(t, \mathbf{X}(t)) dt + \sum_{j=1}^{M} \mathbf{B}^{j}(t, \mathbf{X}(t)) dW^{j}(t),$$
(1)

where  $\mathbf{A}: \langle 0, T \rangle \times \mathbb{R}^N \to \mathbb{R}^N$  is a vector function,  $\mathbf{B}^j$  represents the *j*-th column of the matrix function  $\mathbf{B}: \langle 0, T \rangle \times \mathbb{R}^N \to \mathbb{R}^{N \times M}$  and  $d\mathbf{W}(t) = (dW^1(t), \dots, dW^M(t))$  is a column vector, where  $W^1(t), \dots, W^M(t)$  are independent Wiener processes representing the noise. (A stochastic process W(t) is called the Wiener process if it has independent increments, W(0) = 0 and W(t) - W(s) distributed  $N(0, t - s), 0 \leq s < t$ ). The solution is a stochastic vector process  $\mathbf{X}(t) = (X^1(t), \dots, X^N(t))$ . By an SDE we understand in fact an integral equation

$$\mathbf{X}(t) = \mathbf{X}_0 + \int_{t_0}^t \mathbf{A}(s, \mathbf{X}(s)) \, \mathrm{d}s + \sum_{j=1}^M \int_{t_0}^t \mathbf{B}^j(s, \mathbf{X}(s)) \, \mathrm{d}W^j(s),$$
(2)

where the integral with respect to ds is the Lebesgue integral and the integrals with respect to  $dW^{j}(s)$  are stochastic integrals, called the Itô integrals (see [5]).

Although the Itô integral has some very convenient properties, the usual chain rule of classical calculus doesn't hold. Instead, the appropriate stochastic chain rule, known as Itô formula, contains an additional term, which, roughly speaking, is due to the fact that the stochastic differential  $(dW(t))^2$  is equal to dt in the mean square sense, i.e.  $E[(dW(t))^2] = dt$ , so the second order term in dW(t) should really appear as a first order term in dt.

The multidimensional Itô formula. Let the stochastic process  $\mathbf{X}(t)$  be a solution of the stochastic differential equation (1) for some suitable matrix functions  $\mathbf{A}, \mathbf{B}$ (see [5], p. 48). Let  $\mathbf{g}(t, \mathbf{x}) : (0, \infty) \times \mathbf{R}^N \to \mathbf{R}^P$  is a twice continuously differentiable function. Then

 $\mathbf{Y}(t) = \mathbf{g}(t, \mathbf{X}(t)) = (g_1(t, \mathbf{X}), \dots, g_P(t, \mathbf{X}))$ 

is a stochastic process, whose k-th component is given by

$$dY^{k} = \frac{\partial g_{k}}{\partial t}(t, \mathbf{X}) dt + \sum_{i} \frac{\partial g_{k}}{\partial x_{i}}(t, \mathbf{X}) dX^{i} + \frac{1}{2} \sum_{i,j} \frac{\partial^{2} g_{k}}{\partial x_{i} \partial x_{j}}(t, \mathbf{X}) (dX^{i}) (dX^{j}),$$
(3)

where  $dX^i \cdot dX^j$  is computed according to the rules  $dt \cdot dt = dt \cdot dW^i = dW^i \cdot dt = 0$  and  $dW^i \cdot dW^j = \delta_{i,j} dt$ .

# 2. SIMULATIONS OF THE STOCHASTIC SOLUTION

To simulate the solution of a stochastic differential equation numerical techniques have to be used (see [4]). The simplest numerical scheme, the stochastic Euler scheme, is based on numerical methods for ordinary differential equations.

Let us consider an equidistant discretisation of the time interval  $\langle t_0, T \rangle$  as

$$t_n = t_0 + nh$$
, where  $h = \frac{T - t_0}{n} = t_{n+1} - t_n = \int_{t_n}^{t_{n+1}} dt$ 

and the corresponding discretisation of the j-th component of the Wiener process as

$$\Delta W_n^j = W^j(t_{n+1}) - W^j(t_n) = \int_{t_n}^{t_{n+1}} dW^j(s)$$

To be able to apply any stochastic numerical scheme, first we have to generate, for all *j*, the random increments of  $W^j$  as independent Gauss random variables with mean  $E[\Delta W_n^j] = 0$  and  $E[(\Delta W_n^j)^2] = h$ .

The Euler scheme for the i-th component of an N dimensional stochastic differential equation has the form

$$X_{n+1}^{i} = X_{n}^{i} + A^{i}(t_{n}, \mathbf{X}_{n})h + \sum_{j=1}^{M} B^{i,j}(t_{n}, \mathbf{X}_{n})\Delta W_{n}^{j}.$$
 (4)

For measuring the accuracy of a numerical solution to an SDE we use the strong order of convergence. We say that a

stochastic numerical scheme converges with strong order  $\gamma$  From this we get the solution if there exist real constants K > 0 and  $\delta > 0$ , so that

$$E[|X_T - X_T^h|] \le Kh^{\gamma}, \quad h \in (0, \delta)$$
(5)

where the numerical solution is denoted by  $X_T^h$ . The Euler scheme converges with strong order  $\gamma = \frac{1}{2}$ .

#### 3. MODELLING AN RL CIRCUIT WITH STOCHASTIC SOURCE

We want to apply the Itô stochastic calculus to an electrical problem like in [3]. We will consider inductor-resistor electrical circuits. The electrical current i(t) at time t in a simple RL electrical circuit satisfies the differential equation

$$L \frac{d i(t)}{dt} + Ri(t) = v(t), \quad i(0) = i_0,$$
(6)

where the resistance R and the inductance L are constants and v(t) denotes the potential source at time t (see [2]). Now let us allow some randomness in the potential source. Instead of v(t) we consider the non deterministic version of this function:

$$v^{*}(t) = v(t) +$$
 "noise"

To be able to substitute this into the equation of the circuit we have to describe mathematically the "noise". It is reasonable to look at it as a stochastic process  $\xi(t)$  called the "white noise process". We get the following equation ( $\alpha$  is a constant)

$$L \frac{d i(t)}{dt} + Ri(t) = v(t) + \alpha \xi(t), \quad i(0) = i_0.$$
(7)

From the mathematical point of view the white noise is not very suitable. We multiply the equation by dt and then we replace  $\xi(t) dt$  by a term dW(t). There W(t) is the Wiener proces. Formally the "white noise" is the time derivative of the Wiener process W(t). We get a stochastic differential equation

$$dI(t) = \left(\frac{1}{L}v(t) - \frac{R}{L}I(t)\right)dt + \frac{\alpha}{L} dW(t),$$
(8)

where  $I(0) = I_0$ . We consider both the initial condition and the current at time t as random variables and denote them by capital letters.

To solve this equation we compute, using the Itô formula, the derivative of the function

$$\begin{split} g(t,I(t)) &= \mathrm{e}^{\frac{Rt}{L}}I(t):\\ \mathrm{d}g(t,I(t)) &= \mathrm{d}\left(\mathrm{e}^{\frac{Rt}{L}}I(t)\right) = \mathrm{e}^{\frac{Rt}{L}}\frac{R}{L}I(t) \ \mathrm{d}t + \mathrm{e}^{\frac{Rt}{L}} \ \mathrm{d}I(t) = \\ &= \mathrm{e}^{\frac{Rt}{L}}\left(\frac{R\,I(t)}{L} \ \mathrm{d}t + \frac{v(t)}{L} \ \mathrm{d}t - \frac{R\,I(t)}{L} \ \mathrm{d}t + \frac{\alpha}{L} \ \mathrm{d}W(t)\right) = \\ &= \mathrm{e}^{\frac{Rt}{L}}\frac{v(t)}{L} \ \mathrm{d}t + \mathrm{e}^{\frac{Rt}{L}}\frac{\alpha}{L} \ \mathrm{d}W(t). \end{split}$$

$$I(t) = e^{-\frac{Rt}{L}} I(0) + \frac{1}{L} \int_0^t e^{\frac{R(s-t)}{L}} v(s) \, ds + + \frac{\alpha}{L} \int_0^t e^{\frac{R(s-t)}{L}} \, dW(s).$$
(10)

The solution I(t) is a random process and for it's expectation we have for every t > 0

$$E[I(t)] = e^{\frac{-Rt}{L}} \cdot E[I_0] + \frac{1}{L} \int_0^t e^{\frac{R(s-t)}{L}} \cdot v(s) \, \mathrm{d}s. \tag{11}$$

The second moment  $D(t) = E[I(t)^2]$  can be computed as a solution of the ordinary differential equation

$$\frac{\mathrm{d}\,D(t)}{\mathrm{d}t} = \left(-\frac{2R}{L}\right)D(t) + 2m(t)\frac{v(t)}{L} + \frac{\alpha^2}{L^2},\tag{12}$$

when  $D(0) = E[I^2(0)]$  and m(t) = E[I(t)].

The solution I(t) is a Gaussian process. That means, that I(t) is distributed  $N(m(t), \sigma^2(t))$  for every  $t \in \langle 0, T \rangle$ , where m(t) = E[I(t)] and  $\sigma^2(t) = E[I(t)^2] - m^2(t)$ . Based on the properties of the normal distribution, we can compute in any t, that

$$P(|I(t) - m(t)| < 1.96 \sigma(t)) = 2 \Phi(1.96) - 1 = 0.95,$$

where

$$\Phi(x) = \frac{1}{2\pi} \int_{-\infty}^{x} e^{-\frac{1}{2}s^{2}} \, ds.$$
(13)

As we are able to compute  $E[I(t)^2]$  and m(t) = E[I(t)], we can predict with a probability 95% the interval (m(t) - m(t)) $-\varepsilon$ ,  $m(t) + \varepsilon$ , where the trajectories of the stochastic solution take place.

**Example 1.** Let us consider the *RL* electrical circuit, when *L*, *R* and *v*(*t*) are constants, I(0) = 0,  $\alpha = 1$ . In that case the expectation of the stochastic solution is equal to the classical solution of the circuit. Using the Euler method we plot the stochastic solution together with the deterministic solution (Fig. 1).

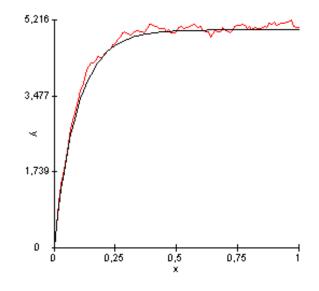


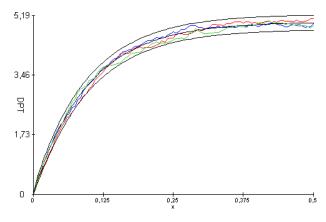
Fig. 1 The deterministic solution and a sample path of the stochastic solution

15

ISSN 1335-8243 © 2008 FEI TUKE

(9)

In Fig. 2 we graph the 95% prediction interval for the trajectories of the stochastic solution. This result was verified in an experiment by measurements on inductor-resistor electrical circuits.



**Fig. 2** Three trajectories of the stochastic solution and a 95% prediction interval

## 4. *RL* CIRCUITS WITH TWO STOCHASTIC PA-RAMETERS

Now we allow some randomness in the electrical source as well as in the resistance. We consider

$$v^*(t) = v(t) +$$
 "noise",  $R^* = R +$  "noise".

The stochastic differential equation describing this situation is

$$\mathrm{d}I(t) = \frac{v(t) - RI(t)}{L} \,\mathrm{d}t - \frac{\beta}{L}I(t) \,\mathrm{d}W_2(t) + \frac{\alpha}{L} \,\mathrm{d}W_1(t),$$

 $I(0) = I_0$ , where  $\alpha$  and  $\beta$  are non negative constants. Their magnitudes determine the deviation of the stochastic case from the deterministic one. To find the solution, we first have to define a function  $F(t) = e^{\frac{R}{L}t + \frac{\beta^2}{2L^2}t + \frac{\beta}{L}W_2(t)}$ , (see [5], p. 77, exercise 5.16) and then compute

$$dF(t) I(t) = d\left(e^{\frac{R}{L}t + \frac{\beta^2}{2L^2}t + \frac{\beta}{L}W_2(t)} I(t)\right).$$
 (14)

applying the multidimensional Itô formula to the function  $g(t,x,y): (0,\infty) \times \mathbb{R}^2 \to \mathbb{R},$ 

$$g(t,x,y) := e^{\frac{R}{L}t + \frac{\beta^2}{2L^2}t + \frac{\beta}{L}x}y.$$
 (15)

We obtain

$$dg(t, W_{2}(t), I(t)) = d\left(e^{\frac{R}{L}t + \frac{\beta^{2}}{2L^{2}}t + \frac{\beta}{L}W_{2}(t)}I(t)\right) = = d(F(t)I(t)) = F(t)\left(\frac{R}{L} + \frac{\beta^{2}}{2L^{2}}\right)I(t) dt + + F(t)\frac{\beta}{L}I(t) dW_{2}(t) + F(t) dI(t) + + \frac{1}{2}\frac{\beta^{2}}{L^{2}}F(t)I(t)\underbrace{(dW_{2}(t))^{2}}_{=dt} + F(t)\frac{\beta}{L}(dW_{2}(t) dI(t)) =$$
(16)

$$= F(t) \left( \left( \frac{R}{L} + \frac{\beta^2}{2L^2} \right) I(t) dt + \frac{\beta}{L} I(t) dW_2(t) \right) +$$
  
+  $F(t) \left( \frac{v(t) - RI(t)}{L} dt - \frac{\beta}{L} I(t) dW_2(t) + \frac{\alpha}{L} dW_1(t) \right) +$   
+  $F(t) \left( \frac{1}{2} \frac{\beta^2}{L^2} I(t) dt + \frac{\beta}{L} \left( -\frac{\beta}{L} I(t) \right) dt \right) =$   
=  $F(t) \left( \frac{v(t)}{L} dt + \frac{\alpha}{L} dW_1(t) \right).$ 

Now there is no I(t) on the righthand side of the equation. We have

$$d(F(t) I(t)) = F(t) \left(\frac{v(t)}{L} dt + \frac{\alpha}{L} dW_1(t)\right).$$
(17)

We can write:

$$F(t)I(t) - F(0)I(0) =$$
  
=  $\frac{1}{L} \int_0^t v(s)F(s) \, ds + \frac{\alpha}{L} \int_0^t F(s) \, dW_1(t).$  (18)

Multiplying this equation by  $F^{-1}(t)$  we get the stochastic solution of the *RL* circuit as a stochastic process

$$I(t) = I_0 e^{-\frac{R}{L}t - \frac{\beta^2}{2L^2}t - \frac{\beta}{L}W_2(t)} + \frac{1}{L} \int_0^t v(s) e^{\frac{R}{L}(s-t) + \frac{\beta^2}{2L^2}(s-t) + \frac{\beta}{L}(W_2(s) - W_2(t))} ds + \frac{\alpha}{L} \int_0^t e^{\frac{R}{L}(s-t) + \frac{\beta^2}{2L^2}(s-t) + \frac{\beta}{L}(W_2(s) - W_2(t))} dW_1(s).$$
(19)

Reference [1], p. 142–143, shows that if  $E[I_0^2] < \infty$ , the expectation E[I(t)] = m(t) is the solution of the ordinary differential equation

$$\frac{\mathrm{d}\,m(t)}{\mathrm{d}t} = \frac{1}{L}(v(t) - R\,m(t)), \quad m(0) = E[I_0]. \tag{20}$$

We can easily compute that

$$E[I(t)] = e^{\frac{-Rt}{L}} \cdot E[I_0] + \frac{1}{L} \int_0^t e^{\frac{R(s-t)}{L}} \cdot v(s) \, \mathrm{d}s, \tag{21}$$

for every t > 0. If the random variable  $I(0) = I_0$  is constant, then the expectation of the stochastic solution is equal to the deterministic solution of the circuit. So the function m(t) = E[I(t)] is independent of the fluctuational part of the stochastic differential equation.

The second moment  $D(t) = E[I^2(t)]$  is the solution of the ordinary linear equation

$$\frac{\mathrm{d}\,D(t)}{\mathrm{d}t} = \left(\frac{\beta^2}{L^2} - \frac{2R}{L}\right)D(t) + 2m(t)\frac{v(t)}{L} + \frac{\alpha^2}{L^2},\tag{22}$$
$$D_0 = E[I_0^2], \text{ where } m(t) = E[I(t)].$$

In this case I(t) is not a Gaussian process, but we can get some prediction interval  $(m(t) - \varepsilon, m(t) + \varepsilon)$  for the trajectories of the stochastic solution using the Chebyshev's inequality. For  $t \in \langle 0, T \rangle$ 

$$P(|I(t) - m(t)| < 2 \sigma(t)) \ge 0.75$$
 (23)

ISSN 1335-8243 © 2008 FEI TUKE

or

$$P(|I(t) - m(t)| < 3 \sigma(t)) \ge \frac{8}{9} = 0.\overline{8}.$$
 (24)

**Example 2**. Let us again consider the *RL* electrical circuit, when *L*, *R* and v(t) are constants,  $I_0 = 0$ ,  $\alpha = 1$ ,  $\beta = 1$ . Using the Euler scheme we compute and graph some sample paths of the stochastic solution of the *RL* circuit together with a prediction interval computed from the Chebyshev's inequality.

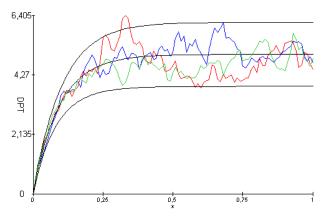
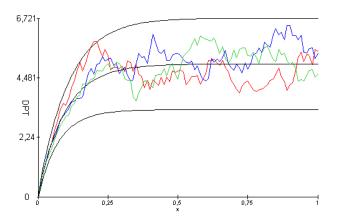


Fig. 3 Three trajectories of the stochastic solution and a prediction interval, where  $P(|I(t) - m(t)| < 2 \sigma(t)) \ge 0.75$ 



**Fig. 4** Three trajectories of the stochastic solution and a prediction interval, where  $P(|I(t) - m(t)| < 3 \sigma(t)) \ge 0.\overline{8}$ 

The pictures are generated in C# (see [7] and [6]).

#### 5. CONCLUSION

This paper shows some applications of the Itô stochastic calculus to the problems of modelling inductor-resistor electrical circuits. The deterministic model of the circuit is replaced by a stochastic model by adding a noise term to the source, in second case in both the source and the resistance. The analytic solution of the resulting stochastic differential equations are obtained using the multidimensional Itô formula. Statistical estimates of the stochastic solutions are examined and confidence intervals are found for the trajectories of the solution. The programming language C#, a part of the new MS .NET platform, is used for numerical simulations. The stochastization of the problem contains two independent white noises, which are artificial, but the results were verified in an experiment by measurements on inductor-resistor electrical circuits.

### ACKNOWLEDGEMENT

The paper was prepared with the support of the research plan MSM 0021 630516.

#### REFERENCES

- [1] Arnold, L.: Stochastic Differential Equations: Theory and Applications, John Wiley & Sons, 1974.
- [2] Halliday, D., Resnick, R., Walker, J.: Fundamentals of Physics, John Wiley & Sons, 1997.
- [3] Kamarianakis, Y., Frangos, N. : Deterministic and stochastic differential equation modelling for electrical networks, HERCMA (Hellenic and European Research in Computational Mathematics) Conference, Athens University of Economics & Business, 2001
- [4] Kloeden, P., Platen, E., Schurz: Numerical Solution Of SDE Through Computer Experiments, Springer-Verlag, 1997.
- [5] Øksendal, B.: Stochastic Differential Equations, An Introduction with Applications, Springer-Verlag, 2000.
- [6] Török, Cs. et al.: Professional Windows GUI Programming: Using C#, Chicago: Wrox Press Inc, 2002, ISBN 1-861007-66-3
- [7] Török, Cs: Visualization and Data Analysis in the MS .NET Framework, Communication of JINR, Dubna, 2004, E10-2004-136

Received January 17, 2008, accepted May 19, 2008

### BIOGRAPHY

**Edita Kolářová** was born on 22.6.1965. In 1988 she graduated at the Faculty of Mathematics and Physics, Charles University, Prague. She defended her PhD in the field of mathematical engineering in 2006; her thesis title was "Stochastic differential equations in electrotechnics". Since 1999 she has been working as a tutor at the Department of Mathematics of the Faculty of Electrical Engineering and Communication, Brno University of Technology. Her scientific research is focusing on application of stochastic differential equations to the problems of electrotechnical engineering.